

FDR8308P

Dual P-Channel, Logic Level, PowerTrench™ MOSFET

General Description

The SuperSOT-8 family of P-Channel Logic Level MOSFETs have been designed to provide a low profile, small footprint alternative to industry standard SO-8 little foot type product.

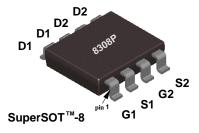
These P-Channel Logic Level MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench process that has been tailored to minimize the on-state resistance and yet maintain superior switching performance.

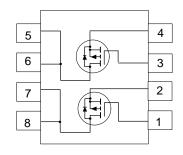
These devices are well suited for portable electronics applications: load switching and power management, battery charging circuits, and DC/DC conversion.

Features

- -3.2 A, -20 V. $R_{DS(ON)} = 0.050~\Omega~@~V_{GS} = -4.5~V,$ $R_{DS(ON)} = 0.070~\Omega~@~V_{GS} = -2.5~V.$
- Low gate charge (13nC typical).
- High performance trench technology for extremely low R_{DS/OND}.
- SuperSOT[™]-8 package: small footprint (40% less than SO-8); low profile(1mmthick); maximum power comparable to SO-8.







Absolute Maximum Ratings $T_A = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	FDR8308P	Units	
DSS	Drain-Source Voltage	-20	V	
GSS	Gate-Source Voltage	±8	V	
	Draint Current - Continuous (Note 1)	-3.2	A	
	- Pulsed	-20		
D	Maximum Power Dissipation (Note 1)	0.8	W	
J,T _{STG}	Operating and Storage Temperature Range	-55 to 150	°C	
HERMA	CHARACTERISTICS			
θJA	Thermal Resistance, Junction-to-Ambient (Note 1)	156	°C/W	
, BJC	Thermal Resistance, Junction-to-Case (Note 1)	40	°C/W	

Symbol	Parameter	ameter Conditions				Max	Units
OFF CHAR	ACTERISTICS						
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$		-20			V
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient	$I_D = -50 \mu\text{A}$, Referenced to	25 °C		-16		mV /°C
I _{DSS}	Zero Gate Voltage Drain Current			-1	μA		
			T _J = 55°C			-10	μA
I _{GSS}	Gate - Body Leakage Current	$V_{GS} = 8 \text{ V}, \ V_{DS} = 0 \text{ V}$	U			100	nA
I _{GSS}	Gate - Body Leakage, Reverse	$V_{GS} = -8 \text{ V}, \ V_{DS} = 0 \text{ V}$				-100	nA
ON CHARAC	CTERISTICS (Note 2)				•	•	•
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$		-0.4	-0.9	-1.5	V
$\Delta V_{GS(th)}/\Delta T_{J}$	Gate Threshold Voltage Temp.Coefficient	$I_D = -50 \mu\text{A}$, Referenced to	25 °C		2.5		mV /°C
R _{DS(ON)}	Static Drain-Source On-Resistance	$V_{GS} = -4.5 \text{ V}, I_{D} = -3.2 \text{ A}$			0.038	0.05	Ω
20(0.1)			T _J = 125°C		0.053	0.075	1
		$V_{GS} = -2.5 \text{ V}, I_{D} = -2.7 \text{ A}$	1 -		0.054	0.07	1
I _{D(ON)}	On-State Drain Current	$V_{GS} = -4.5 \text{ V}, \ V_{DS} = -5 \text{ V}$		-20			Α
g _{FS}	Forward Transconductance	$V_{DS} = -4.5 \text{ V}, I_{D} = -3.2 \text{ A}$			13		S
DYNAMIC C	HARACTERISTICS					•	
C _{iss}	Input Capacitance	$V_{DS} = -10 \text{ V}, \ V_{GS} = 0 \text{ V},$			1240		pF
C _{oss}	Output Capacitance	f = 1.0 MHz	f = 1.0 MHz				pF
C _{rss}	Reverse Transfer Capacitance			100		pF	
SWITCHING	CHARACTERISTICS (Note 2)						
$t_{D(on)}$	Turn - On Delay Time	$V_{DD} = -5 \text{ V}, \ I_{D} = -1 \text{ A},$			8	16	ns
t,	Turn - On Rise Time	$V_{GS} = -4.5 \text{ V}, R_{GEN} = 6 \Omega$			15	27	ns
t _{D(off)}	Turn - Off Delay Time				45	65	ns
t _r	Turn - Off Fall Time				30	50	ns
Q_g	Total Gate Charge	$V_{DS} = -10 \text{ V}, I_{D} = -4.5 \text{ A},$			13	19	nC
Q_{gs}	Gate-Source Charge	V _{GS} = -4.5 V			1.8		nC
Q_{gd}	Gate-Drain Charge				3		nC
DRAIN-SO	URCE DIODE CHARACTERISTICS AND N	IAXIMUM RATINGS					
I _s	Maximum Continuous Drain-Source Diode F				-0.67	Α	
$\overline{V_{SD}}$	Drain-Source Diode Forward Voltage	ote 2)		-0.7	-1.2	V	

Notes:

^{1.} $R_{g,lA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{g,lC}$ is guaranteed by design while $R_{g,CA}$ is determined by the user's board design.



156°C/W on a 0.0025 in² pad of 2oz copper.



Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2.0%.

Typical Electrical Characteristics

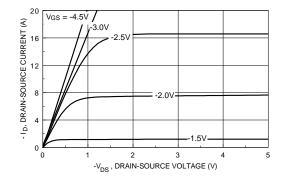


Figure 1. On-Region Characteristics.

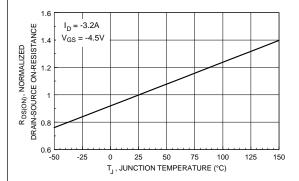


Figure 3. On-Resistance Variation with Temperature.

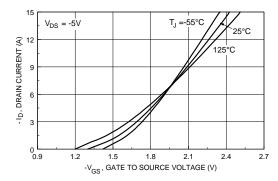


Figure 5. Transfer Characteristics.

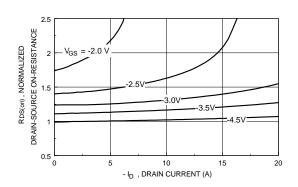


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

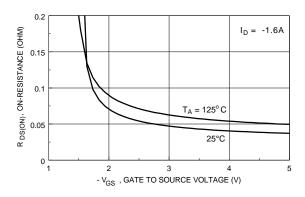


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

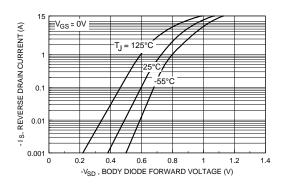
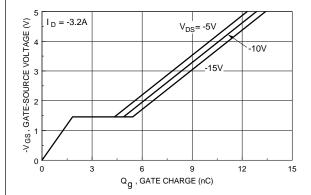


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

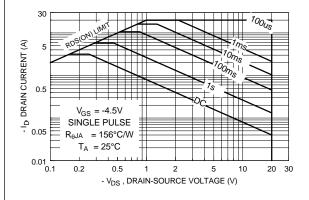
Typical Electrical Characteristics (continued)



2500 Ciss 1000 Ciss 1000 Coss 1000 C

Figure 7. Gate Charge Characteristics.





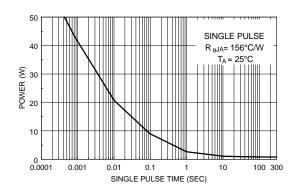


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

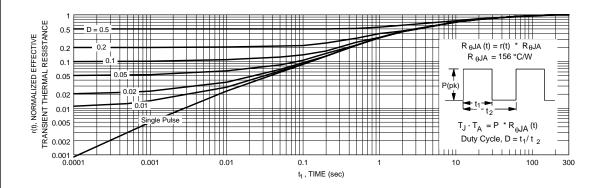
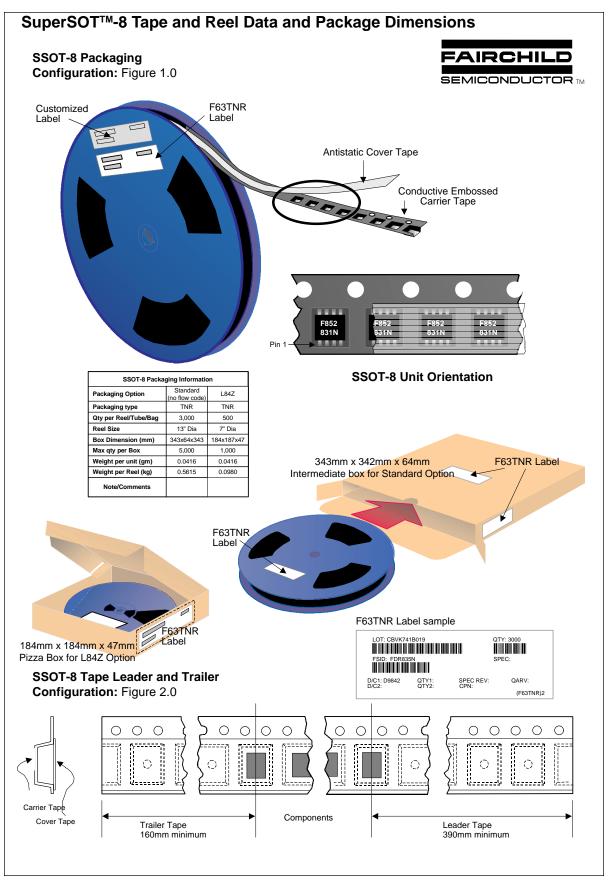


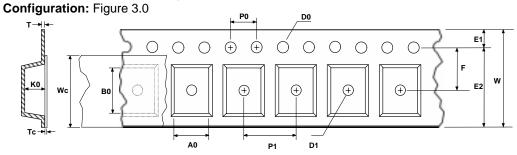
Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in note 1. Transient thermal response will change depending on the circuit board design.





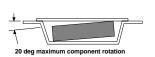
SSOT-8 Embossed Carrier Tape



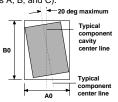
User Direction of Feed	
	_

Dimensions are in millimeter														
Pkg type	Α0	В0	w	D0	D1	E1	E2	F	P1	P0	K0	т	Wc	Тс
SSOT-8 (12mm)	4.47 +/-0.10	5.00 +/-0.10	12.0 +/-0.3	1.55 +/-0.05	1.50 +/-0.10	1.75 +/-0.10	10.25 min	5.50 +/-0.05	8.0 +/-0.1	4.0 +/-0.1	1.37 +/-0.10	0.280 +/-0.150	9.5 +/-0.025	0.06 +/-0.02

Notes: A0, B0, and K0 dimensions are determined with respect to the EIA/Jedec RS-481 rotational and lateral movement requirements (see sketches A, B, and C).



Sketch A (Side or Front Sectional View)
Component Rotation



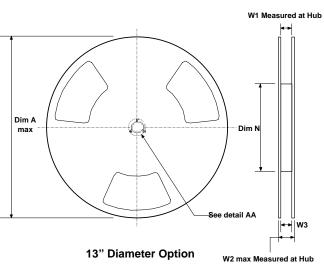
Sketch B (Top View)

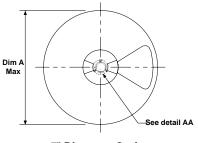
Component Rotation

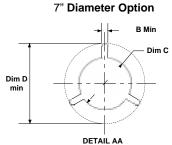


Sketch C (Top View)
Component lateral movement

SSOT-8 Reel Configuration: Figure 4.0



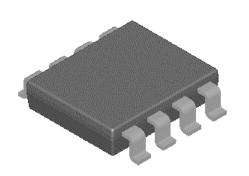


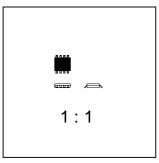


	Dimensions are in inches and millimeters								
Tape Size	Reel Option	Dim A	Dim B	Dim C	Dim D	Dim N	Dim W1	Dim W2	Dim W3 (LSL-USL)
12mm	7" Dia	7.00 177.8	0.059 1.5	512 +0.020/-0.008 13 +0.5/-0.2	0.795 20.2	5.906 150	0.488 +0.078/-0.000 12.4 +2/0	0.724 18.4	0.469 - 0.606 11.9 - 15.4
12mm	13" Dia	13.00 330	0.059 1.5	512 +0.020/-0.008 13 +0.5/-0.2	0.795 20.2	7.00 178	0.488 +0.078/-0.000 12.4 +2/0	0.724 18.4	0.469 - 0.606 11.9 - 15.4

SuperSOT™-8 Tape and Reel Data and Package Dimensions, continued

SuperSOT™-8 (FS PKG Code 34, 35)

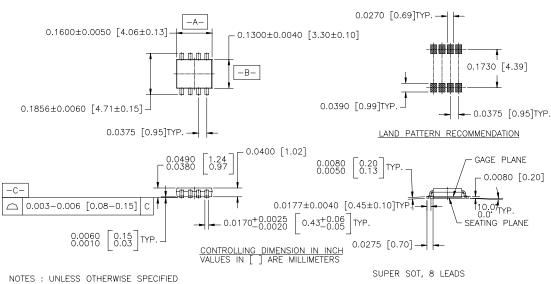




Scale 1:1 on letter size paper

Dimensions shown below are in: inches [millimeters]

Part Weight per unit (gram): 0.0416



STANDARD LEAD FINISH TI BE 200 MICROINCHES / 5.08 MICROMETERS MINIMUM TIN/LEAD (SOLDER) ON COPPER.

2. NO JEDEC REGISTRATION AS JAN. 1996

TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

ACEXTM ISOPLANARTM
CoolFETTM MICROWIRETM

CROSSVOLTTM POPTM

E²CMOS[™] PowerTrench[™]

FACTTM QSTM

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

- 1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the user.
- 2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition					
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.					
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.					
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.					
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.					